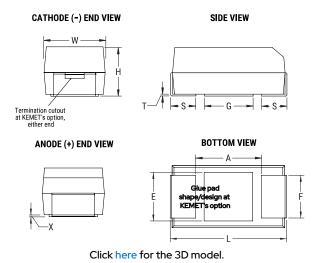


## T5410687M010CH6710

T541 HRA, Tantalum, Polymer Tantalum, HRA Multi-Anode, 680 uF, 20%, 10 VDC, SMD, Polymer, Molded, High Reliability, Multi-Anode, Low ESR, C (0.01%/1000 Hrs), 15 mOhms, 7360, 4.3 mm, 1.3 mm



General Information	
Series	T541HRA
Dielectric	Polymer Tantalum
Style	SMD Chip
Description	SMD, Polymer, Molded, High Reliability, Multi-Anode, Low ESR
Features	Non-Combustible, Multiple Anode, Low ESR, High Reliability
RoHS	No
Prop 65	WARNING: Cancer and reproductive harm - https://www.p65warnings.ca.gov /
SCIP Number	b064b03e-bd75-42af-b342-1fe 94dec2340
Termination	Tin Lead (SnPb)
AEC-Q200	No
Shelf Life	52 Weeks
MSL	3

Dimensions	
L	7.3mm +/-0.3mm
W	6mm +/-0.3mm
Н	4mm +/-0.3mm
Т	0.13mm REF
S	1.3mm +/-0.3mm
F	4.1mm +/-0.1mm
A	3.8mm MIN
E	3.5mm REF
G	3.5mm REF
X	0.1mm +/-0.1mm REF

E	3.5mm REF
G	3.5mm REF
X	0.1mm +/-0.1mm REF
Packaging Specifications	
Packaging	T&R, 178mm
Packaging Quantity	250

Specifications	
Capacitance	680 uF
Tolerance	20%
Voltage DC	10 VDC (105C), 6.7 VDC (125C)
Temperature Range	-55/+125°C
Rated Temperature	105°C
Life	2000 Hrs (125C)
Humidity	60C, 90% RH, 500 Hours, rated voltage
Dissipation Factor	10% 120Hz 25C
Failure Rate	C (0.01%/1000 Hrs)
ESR	15 mOhms (100kHz 25C)
Ripple Current	4470 mA (rms, 100kHz 45C)
Leakage Current	680 uA (5min 25°C)
Testing and Reliability	10 Cycles Surge Current Testing At -55C +0C/-5C And +85C +/-5C After Voltage Aging

Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

Generated 05/04/2025 © 2006 - 2025 YAGEO